

ESD Protection Diode

Micro-Packaged Diodes for ESD Protection ESD7382MUT5G

The ESD7382 is designed to protect voltage sensitive components that require ultra-low capacitance from ESD and transient voltage events. Excellent clamping capability, low capacitance, low leakage, and fast response time, make these parts ideal for ESD protection on designs where board space is at a premium. Because of its low capacitance, it is suited for use in high frequency designs such as USB 2.0 high speed and antenna line applications.



• Ultra-Low Capacitance: 0.37 pF

• Low Clamping Voltage

• Small Body Outline Dimensions: 0.60 mm x 0.30 mm

• Low Body Height: 0.3 mm • Stand-off Voltage: 5.0 V

• Low Leakage

• Insertion Loss: 0.030 dBm

• Response Time is < 1 ns • Low Dynamic Resistance $< 1 \Omega$

• IEC61000-4-2 Level 4 ESD Protection

• These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

Typical Applications

• GPIO and Power Line Protection

MAXIMUM RATINGS

Rating	Symbol	Value	Unit
IEC 61000-4-2 (ESD) Contact Air		±20 ±20	kV
Total Power Dissipation on FR-5 Board (Note 1) @ T _A = 25°C Thermal Resistance, Junction-to-Ambient	P_{D} $R_{ hetaJA}$	250 400	mW °C/W
Junction and Storage Temperature Range	T _J , T _{stg}	-40 to +125	°C
Lead Solder Temperature – Maximum (10 Second Duration)	TL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. $FR-5 = 1.0 \times 0.75 \times 0.62$ in.

O 2 Cathode Anode

MARKING DIAGRAM

PIN 1



X3DFN2 CASE 152AF



= Specific Device Code (Rotated 270°)

= Date Code

ORDERING INFORMATION

Device	Package	Shipping [†]
ESD7382MUT5G	X3DFN2 (Pb-Free)	10,000 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

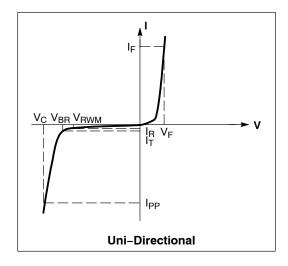
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ELECTRICAL CHARACTERISTICS

(T_A = 25°C unless otherwise noted)

Symbol	Parameter		
I _{PP}	Maximum Reverse Peak Pulse Current		
V _C	Clamping Voltage @ I _{PP}		
V _{RWM}	Working Peak Reverse Voltage		
I _R	Maximum Reverse Leakage Current @ V _{RWM}		
V _{BR}	Breakdown Voltage @ I _T		
I _T	Test Current		

^{*}See Application Note AND8308/D for detailed explanations of datasheet parameters.



ELECTRICAL CHARACTERISTICS (T_A = 25°C unless otherwise specified)

Parameter	Symbol	Conditions	Min	Тур	Max	Unit
Reverse Working Voltage	V_{RWM}				5.0	V
Breakdown Voltage (Note 2)	V_{BR}	I _T = 1 mA	5.2			V
Reverse Leakage Current	I _R	V _{RWM} = 5.0 V			1.0	μΑ
Clamping Voltage (Note 3)	V _C	I _{PP} = 1 A			8.0	V
Clamping Voltage (Note 3)	V _C	I _{PP} = 3 A			10	V
ESD Clamping Voltage	V _C	Per IEC61000-4-2	See Figures 1 and 2			
Junction Capacitance	СЈ	$V_R = 0 \text{ V, } f = 1 \text{ Mhz}$ $V_R = 0 \text{ V, } f < 1 \text{ GHz}$		0.37 0.25	0.55 0.55	pF
Dynamic Resistance	R_{DYN}	TLP Pulse		0.32		Ω
Insertion Loss		f = 1 Mhz f = 8.5 GHz		0.030 0.573		dB

- 2. Breakdown voltage is tested from pin 1 to 2 and pin 2 to 1.
- 3. Non-repetitive current pulse at $T_A = 25$ °C, per IEC61000-4-5 waveform.

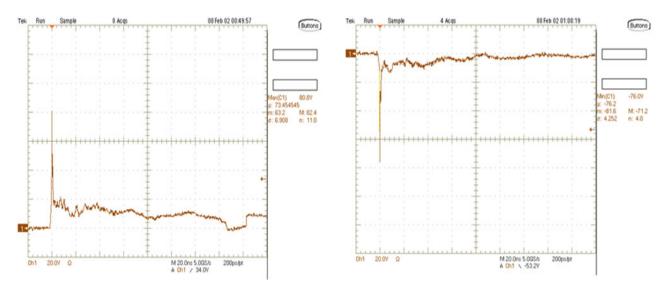
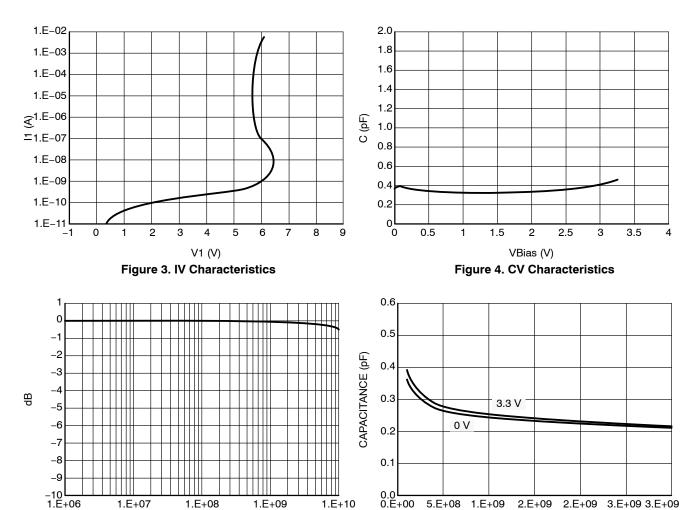


Figure 1. ESD Clamping Voltage Screenshot Positive 8 kV Contact per IEC61000-4-2

Figure 2. ESD Clamping Voltage Screenshot Negative 8 kV Contact per IEC61000-4-2



FREQUENCY (Hz) Figure 5. RF Insertion Loss

1.E+08

1.E+09

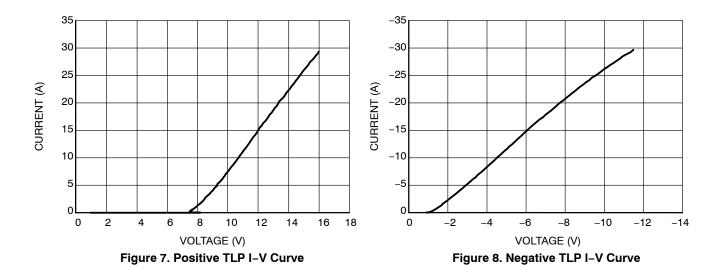
1.E+07

FREQUENCY Figure 6. Capacitance over Frequency

5.E+08

1.E+09

2.E+09 2.E+09 3.E+09 3.E+09



1.E+10

IEC 61000-4-2 Spec.

	_			
Level	Test Volt- age (kV)	First Peak Current (A)	Current at 30 ns (A)	Current at 60 ns (A)
1	2	7.5	4	2
2	4	15	8	4
3	6	22.5	12	6
4	8	30	16	8

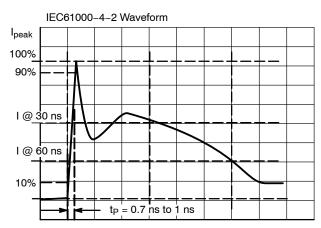


Figure 9. IEC61000-4-2 Spec

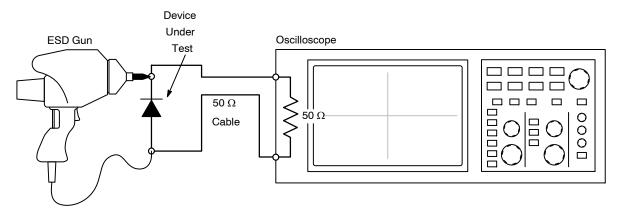


Figure 10. Diagram of ESD Test Setup

ESD Voltage Clamping

For sensitive circuit elements it is important to limit the voltage that an IC will be exposed to during an ESD event to as low a voltage as possible. The ESD clamping voltage is the voltage drop across the ESD protection diode during an ESD event per the IEC61000-4-2 waveform. Since the IEC61000-4-2 was written as a pass/fail spec for larger systems such as cell phones or laptop computers it is not

clearly defined in the spec how to specify a clamping voltage at the device level. **onsemi** has developed a way to examine the entire voltage waveform across the ESD protection diode over the time domain of an ESD pulse in the form of an oscilloscope screenshot, which can be found on the datasheets for all ESD protection diodes. For more information on how **onsemi** creates these screenshots and how to interpret them please refer to AND8307/D.

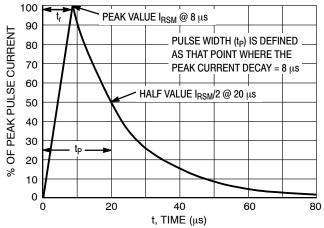
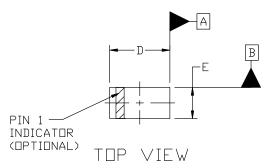


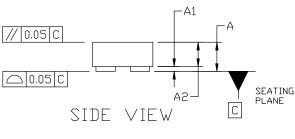
Figure 11. 8 X 20 µs Pulse Waveform

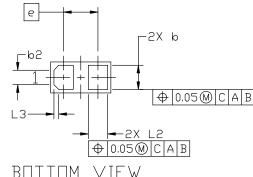
PACKAGE DIMENSIONS

X3DFN2 0.62x0.32x0.24, 0.35P

CASE 152AF ISSUE C



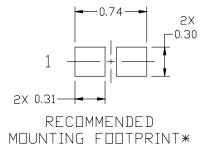




NOTES:

- . DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
- 2. CONTROLLING DIMENSION: MILLIMETERS
- 3. 0201

	MILLIMETERS		
DIM	MIN.	N□M.	MAX.
А	0.25	0.29	0.33
A1	0.00		0.05
A2	0.14	0.24	0.34
b	0.22	0,25	0.28
b2	0.150 REF		
D	0.58	0.62	0.66
E	0.28	0.32	0.36
е	0.355 BSC		
L2	0.17	0.20	0.23
L3	0.050 REF		



For additional information on our Pb-Free strategy and soldering details, please download the □N Semiconductor Soldering and Mounting Techniques Reference Manual, S□LDERRM/D.

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